



CY7C187A

64K x 1 Static RAM

Features

- High speed
— 20 ns
- CMOS for optimum speed/power
- Low active power
— 495 mW
- Low standby power
— 220 mW
- TTI-compatible inputs and outputs
- Automatic power-down when deselected

Functional Description

The CY7C187A is a high-performance CMOS static RAM organized as 65,536 words by 1 bit. Easy memory expansion is

provided by an active LOW chip enable ($\overline{CE}$) and three-state drivers. The CY7C187A has an automatic power-down feature, reducing the power consumption by 55% when deselected.

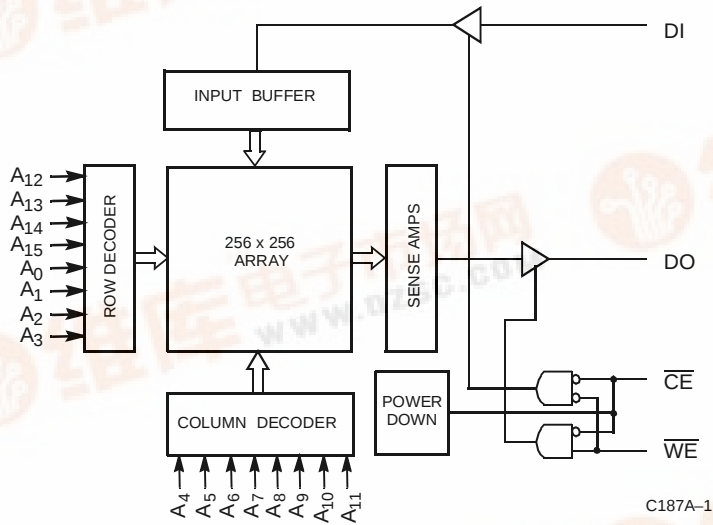
Writing to the device is accomplished when the chip enable ($\overline{CE}$) and write enable ($\overline{WE}$) inputs are both LOW. Data on the input pin (DI) is written into the memory location specified on the address pins (A_0 through A_{15}).

Reading the device is accomplished by taking the chip enable ($\overline{CE}$) LOW, while write enable ($\overline{WE}$) remains HIGH. Under these conditions, the contents of the memory location specified on the address pins will appear on the data output (DO) pin.

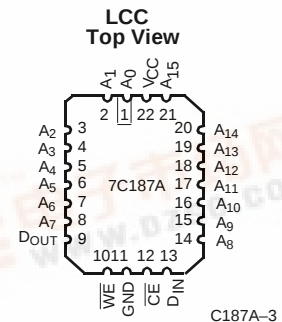
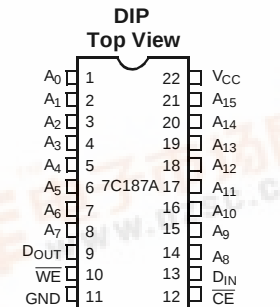
The output pin stays in high-impedance state when chip enable ($\overline{CE}$) is HIGH or write enable ($\overline{WE}$) is LOW.

The 7C187A utilizes a die coat to insure alpha immunity.

Logic Block Diagram



Pin Configurations



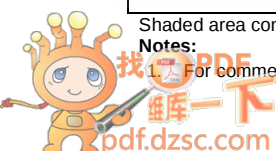
Selection Guide^[1]

		7C187A-15	7C187A-20	7C187A-25	7C187A-35
Maximum Access Time (ns)		15	20	25	35
Maximum Operating Current (mA)	Military	160	90	80	80
Maximum Standby Current (mA)	Military	40/20	40/20	40/20	30/20

Shaded area contains preliminary information.

Notes:

1. For commercial specifications, see CY7C187 datasheet.





CY7C187A

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C

Ambient Temperature with
Power Applied -55°C to +125°C

Supply Voltage to Ground Potential
(Pin 22 to Pin 11) -0.5V to +7.0V

DC Voltage Applied to Outputs
in High Z State^[2] -0.5V to +7.0V

DC Input Voltage^[2] -0.5V to +7.0V

Output Current into Outputs (LOW) 20 mA

Static Discharge Voltage >2001V
(per MIL-STD-883, Method 3015)

Latch-Up Current >200 mA

Operating Range

Range	Ambient Temperature	V _{CC}
Military ^[3]	-55°C to +125°C	5V ± 10%

Electrical Characteristics Over the Operating Range^[4]

Parameter	Description	Test Conditions	7C187A-15		7C187A-20		Unit
			Min.	Max.	Min.	Max.	
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = -4.0 mA	2.4		2.4		V
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 12.0 mA		0.4		0.4	V
V _{IH}	Input HIGH Voltage		2.2	V _{CC}	2.2	V _{CC}	V
V _{IL}	Input LOW Voltage ^[2]		-0.5	0.8	-0.5	0.8	V
I _{IX}	Input Load Current	GND ≤ V _I ≤ V _{CC}	-5	+5	-5	+5	μA
I _{OZ}	Output Leakage Current	GND ≤ V _O ≤ V _{CC} , Output Disabled	-5	+5	-5	+5	μA
I _{OS}	Output Short Circuit Current ^[5]	V _{CC} = Max., V _{OUT} = GND		-350		-350	mA
I _{CC}	V _{CC} Operating Supply Current	V _{CC} = Max., I _{OUT} = 0 mA		160		90	mA
I _{SB1}	Automatic $\overline{CE}$ Power-Down Current ^[6]	Max. V _{CC} , $\overline{CE} \geq V_{IH}$		40		40	mA
I _{SB2}	Automatic $\overline{CE}$ Power-Down Current ^[6]	Max. V _{CC} , $\overline{CE} \geq V_{CC} - 0.3V$, V _{IN} ≥ V _{CC} - 0.3V or V _{IN} ≤ 0.3V		20		20	mA

Shaded area contains preliminary information.

Notes:

- V_{IL} (min.) = -3.0V for pulse durations less than 30 ns.
- T_A is the "instant on" case temperature.
- See the last page of this specification for Group A subgroup testing information.
- Not more than 1 output should be shorted at one time. Duration of the short circuit should not exceed 30 seconds.
- A pull-up resistor to V_{CC} on the $\overline{CE}$ input is required to keep the device deselected during V_{CC} power-up, otherwise I_{SB} will exceed values given.



Electrical Characteristics Over the Operating Range^[4] (continued)

Parameter	Description	Test Conditions	7C187A-25		7C187A-35		Unit
			Min.	Max.	Min.	Max.	
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = -4.0 mA	2.4		2.4		V
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 8.0 mA		0.4		0.4	V
V _{IH}	Input HIGH Voltage		2.2	V _{CC}	2.2	V _{CC}	V
V _{IL}	Input LOW Voltage ^[2]		-3.0	0.8	-3.0	0.8	V
I _{IX}	Input Load Current	GND ≤ V _I ≤ V _{CC}	-5	+5	-5	+5	μA
I _{OZ}	Output Leakage Current	GND ≤ V _O ≤ V _{CC} , Output Disabled	-5	+5	-5	+5	μA
I _{OS}	Output Short Circuit Current ^[5]	V _{CC} = Max., V _{OUT} = GND		-350		-350	mA
I _{CC}	V _{CC} Operating Supply Current	V _{CC} = Max., I _{OUT} = 0 mA		80		80	mA
I _{SB1}	Automatic $\overline{CE}$ Power-Down Current ^[6]	Max. V _{CC} , $\overline{CE} \geq V_{IH}$		40		30	mA
I _{SB2}	Automatic $\overline{CE}$ Power-Down Current ^[6]	Max. V _{CC} , $\overline{CE} \geq V_{CC} - 0.3V$, V _{IN} ≥ V _{CC} - 0.3V or V _{IN} ≤ 0.3V		20		20	mA

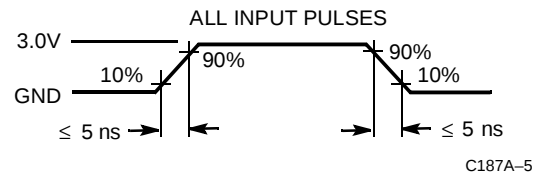
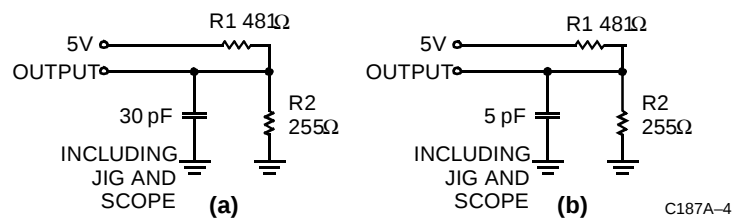
Capacitance^[7]

Parameter	Description	Test Conditions	Max.	Unit
C _{IN}	Input Capacitance	T _A = 25°C, f = 1 MHz, V _{CC} = 5.0V	10	pF
C _{OUT}	Output Capacitance		10	pF

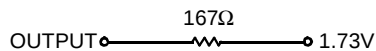
Note:

7. Tested initially and after any design or process changes that may affect these parameters.

AC Test Loads and Waveforms



Equivalent to: THÉVENIN EQUIVALENT





Switching Characteristics Over the Operating Range^[4, 8]

Parameter	Description	7C187A-15		7C187A-20		7C187A-25		7C187A-35		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
READ CYCLE										
t _{RC}	Read Cycle Time	15		20		25		35		ns
t _{AA}	Address to Data Valid		15		20		25		35	ns
t _{OHA}	Output Hold from Address Change	3		3		3		3		ns
t _{ACE}	$\overline{CE}$ LOW to Data Valid		15		20		25		35	ns
t _{LZCE}	$\overline{CE}$ LOW to Low Z ^[9]	3		5		5		5		ns
t _{HZCE}	$\overline{CE}$ HIGH to High Z ^[9,10]		8		8		10		15	ns
t _{PU}	$\overline{CE}$ LOW to Power-Up	0		0		0		0		ns
t _{PD}	$\overline{CE}$ HIGH to Power-Down		15		20		20		20	ns
WRITE CYCLE ^[11]										
t _{WC}	Write Cycle Time	15		20		20		25		ns
t _{SCE}	$\overline{CE}$ LOW to Write End	10		15		20		25		ns
t _{AW}	Address Set-Up to Write End	10		15		20		25		ns
t _{HA}	Address Hold from Write End	0		0		0		0		ns
t _{SA}	Address Set-Up to Write Start	0		0		0		0		ns
t _{PWE}	$\overline{WE}$ Pulse Width	10		15		15		20		ns
t _{SD}	Data Set-Up to Write End	7		10		10		15		ns
t _{HD}	Data Hold from Write End	0		0		0		0		ns
t _{LZWE}	$\overline{WE}$ HIGH to Low Z ^[9]	3		5		5		5		ns
t _{HZWE}	$\overline{WE}$ LOW to High Z ^[9,10]		7		7		7		10	ns

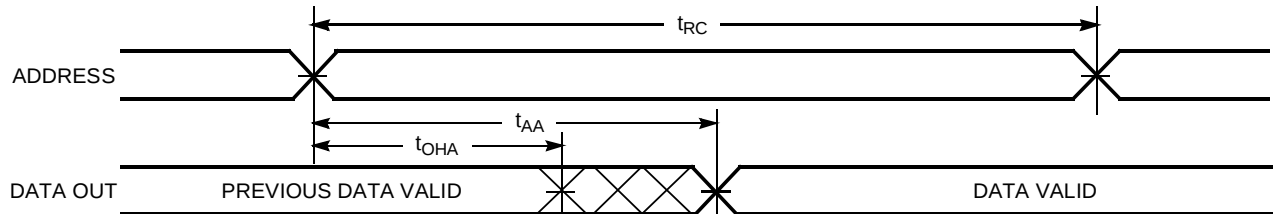
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Notes:

8. Test conditions assume signal transition time of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V, and output loading of the specified I_{OL}/I_{OH} and 30-pF load capacitance.
9. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE} for any given device.
10. t_{HZCE} and t_{HZWE} are specified with C_L = 5 pF as in part (b) of AC Test Loads. Transition is measured ±500 mV from steady-state voltage.
11. The internal write time of the memory is defined by the overlap of CE LOW and WE LOW. Both signals must be LOW to initiate a write and either signal can terminate a write by going HIGH. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the write.

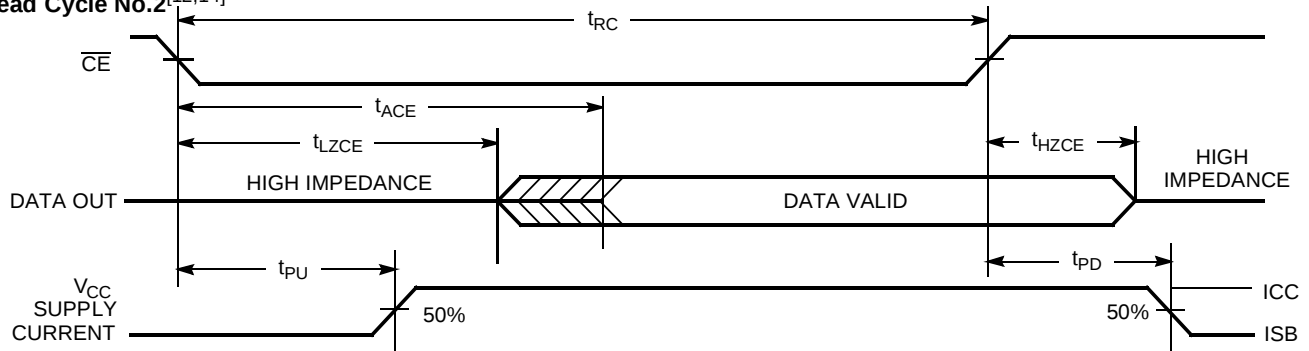
Switching Waveforms

Read Cycle No. 1^[12,13]



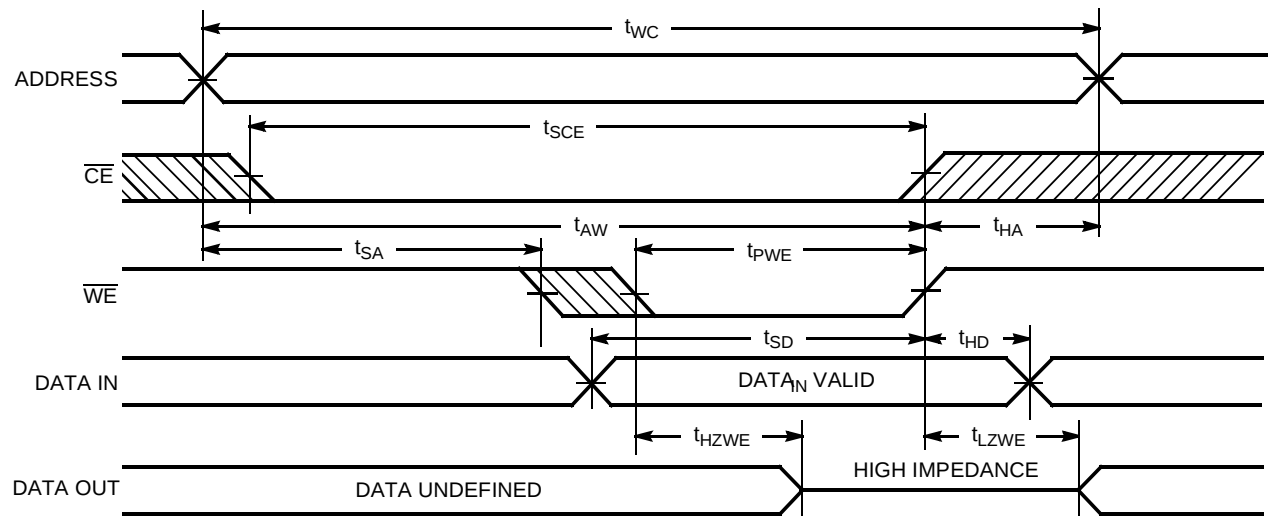
C187A-6

Read Cycle No. 2^[12,14]



C187A-7

Write Cycle No. 1 ($\overline{WE}$ Controlled)^[11]



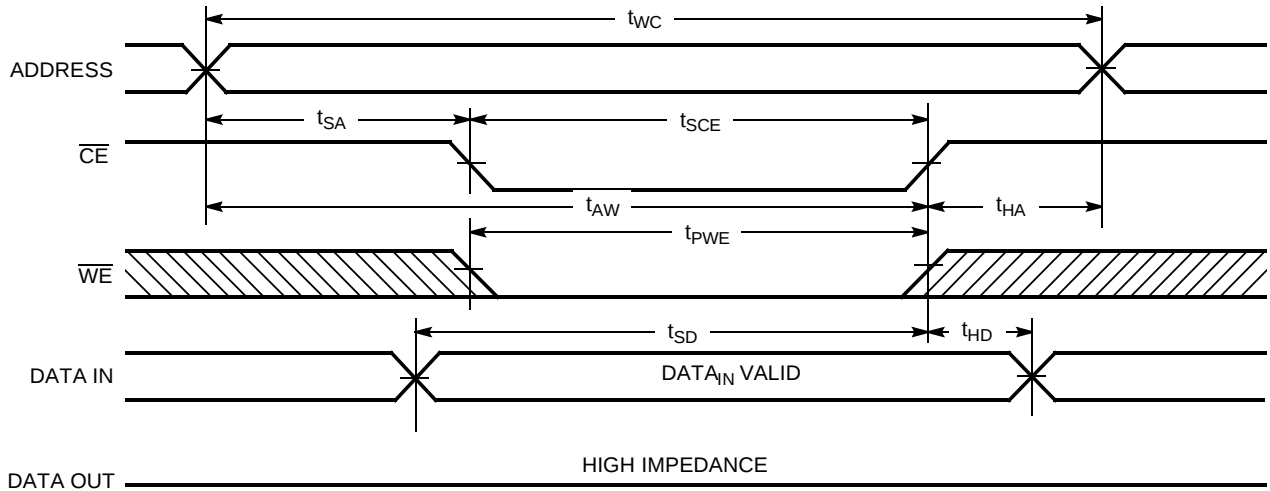
C187A-8

Notes:

12. $\overline{WE}$ is HIGH for read cycle.
13. Device is continuously selected, $\overline{CE} = V_{IL}$.
14. Address valid prior to or coincident with $\overline{CE}$ transition LOW.

Switching Waveforms (Continued)

Write Cycle No.2 ($\overline{\text{CE}}$ Controlled)^[11,15]

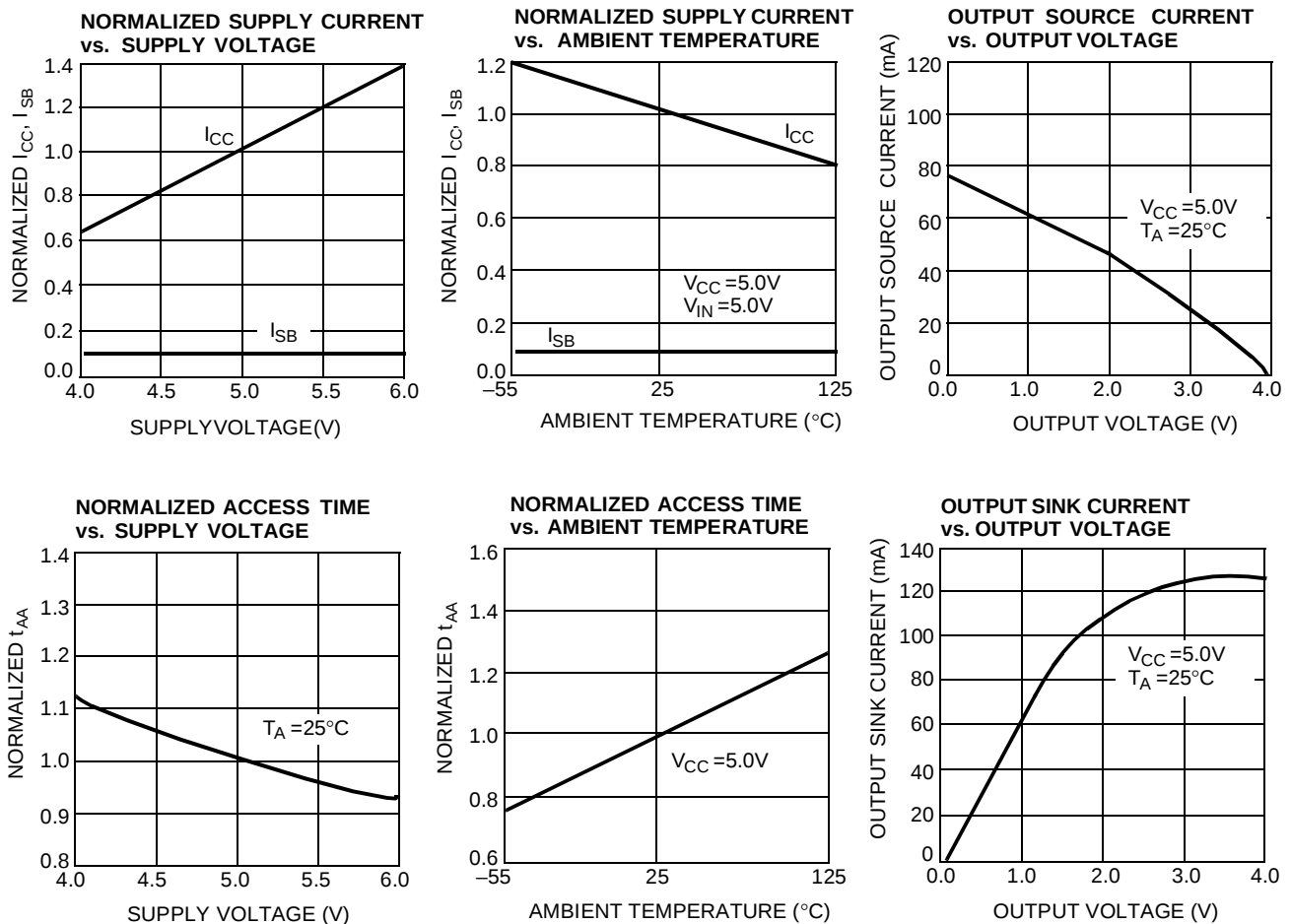


C187A-9

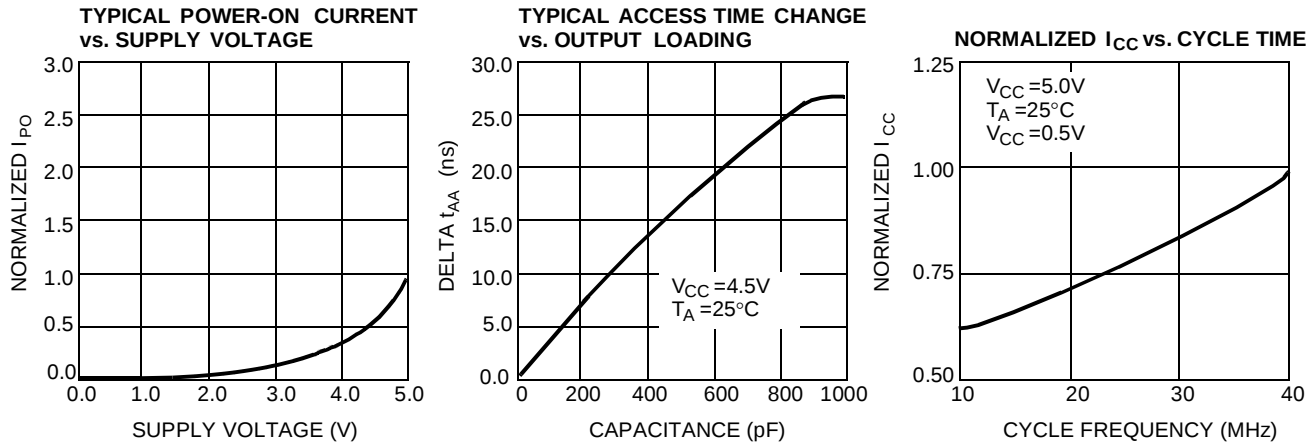
Note:

15. If $\overline{\text{CE}}$ goes HIGH simultaneously with $\overline{\text{WE}}$ HIGH, the output remains in a high-impedance state.

Typical DC and AC Characteristics



Typical DC and AC Characteristics



Address Designators

Address Name	Address Function	Pin Number
A0	X3	1
A1	X4	2
A2	X5	3
A3	X6	4
A4	X7	5
A5	Y7	6
A6	Y6	7
A7	Y2	8
A8	Y3	14
A9	Y1	15
A10	Y0	16
A11	Y4	17
A12	Y5	18
A13	X0	19
A14	X1	20
A15	X2	21

Truth Table

CE	WE	Input/Output	Mode
H	X	High Z	Deselect/Power-Down
L	H	Data Out	Read
L	L	Data In	Write



Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
15	CY7C187A–15DMB	D14	24-Lead (300-Mil) CerDIP	Military
	CY7C187A–15LMB	L52	22-Pin Rectangular Leadless Chip Carrier	
20	CY7C187A–20DMB	D14	24-Lead (300-Mil) CerDIP	Military
	CY7C187A–20LMB	L52	22-Pin Rectangular Leadless Chip Carrier	
25	CY7C187A–25DMB	D14	24-Lead (300-Mil) CerDIP	Military
	CY7C187A–25LMB	L52	22-Pin Rectangular Leadless Chip Carrier	
35	CY7C187A–35DMB	D14	24-Lead (300-Mil) CerDIP	Military
	CY7C187A–35LMB	L52	22-Pin Rectangular Leadless Chip Carrier	

Shaded area contains preliminary information.

MILITARY SPECIFICATIONS

Group A Subgroup Testing

DC Characteristics

Parameter	Subgroups
V_{OH}	1, 2, 3
V_{OL}	1, 2, 3
V_{IH}	1, 2, 3
V_{IL} Max.	1, 2, 3
I_{IX}	1, 2, 3
I_{OZ}	1, 2, 3
I_{OS}	1, 2, 3
I_{CC}	1, 2, 3
I_{SB1}	1, 2, 3
I_{SB2}	1, 2, 3

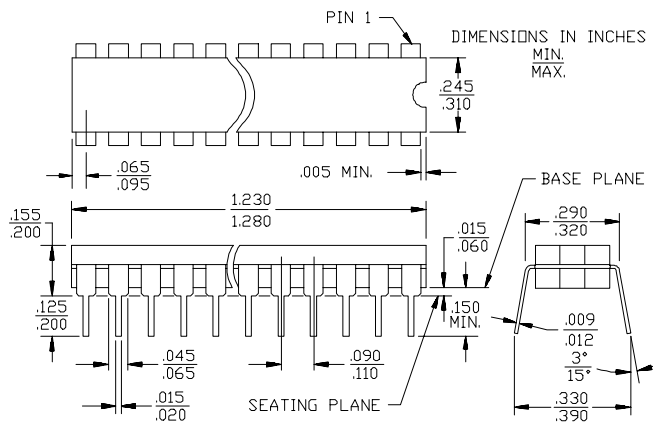
Switching Characteristics

Parameter	Subgroups
READ CYCLE	
t_{RC}	7, 8, 9, 10, 11
t_{AA}	7, 8, 9, 10, 11
t_{OHA}	7, 8, 9, 10, 11
t_{ACE}	7, 8, 9, 10, 11
WRITE CYCLE	
t_{WC}	7, 8, 9, 10, 11
t_{SCE}	7, 8, 9, 10, 11
t_{AW}	7, 8, 9, 10, 11
t_{HA}	7, 8, 9, 10, 11
t_{SA}	7, 8, 9, 10, 11
t_{PWE}	7, 8, 9, 10, 11
t_{SD}	7, 8, 9, 10, 11
t_{HD}	7, 8, 9, 10, 11

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Package Diagrams

24-Lead (300-Mil) CerDIP D14
MIL-STD-1835 D-9 Config.A



22-Pin Rectangular Leadless Chip Carrier L52

